TB-2363

GENERAL PRODUCT SPECIFICATION FOR Paladin HD and HD2 $^{\rm TM}$ INTERCONNECT SYSTEMS

Revision "D"

Specification Revision Status

Revision	SCR No.	Description	Initial	Date
A	S9527	Initial Pre-Release	J Dunham	12/21/21
В	S10704	Engagement force value and drill size updated	S Demian	7/20/23
С	S10873	Separation force value updated	K Vlack	11/10/23
D	S10980	Updated Document to reflect Paladin HD2	A Nachankar	01/22/24

Amphenol TCS

A Division of Amphenol Corporation

1.0 SCOPE

1.1 Content

- 1.1.1 This specification covers the performance, test and quality requirements for the Paladin HD and HD2 interconnect system. These connectors are two-piece devices that connect two printed circuit boards. Receptacle connectors and pin connectors are through hole devices with eye-of-the-needle compliant pin contacts as well as compression contacts. The Paladin HD and HD2 connector family consists of modular configurations with custom guidance modules.
- 1.1.2 Paladin HD and HD2 specification covers the traditional daughtercard to backplane, orthogonal midplane, direct orthogonal (no midplane), cabled backplane and mezzanine.

1.2 Qualification

1.2.1 When tests are performed on subject product line, procedures specified in EIA-364-B shall be used per the test sequences outlined in Amphenol TCS Technical Bulletin TB-2023. All inspections shall be performed using applicable inspection plan and product drawings.

2.0 REFERENCE DOCUMENTS

The following documents form a part of this specification to the extent specified herein.

- 2.1 Amphenol TCS Documents
 - 2.1.1 TB-2023 Amphenol TCS Commercial Connector Qualification Plan
 - 2.1.2 TB-2357 Paladin HD and HD2 Direct Ortho General Guidelines
 - 2.1.3 TB-2360 Paladin HD and HD2 Routing Guidelines
 - 2.1.4 TB-2362 Paladin HD and HD2 Right Angle Press Fit Installation Guidelines
 - 2.1.5 TB-2364 Paladin HD and HD2 Right Angle Connector Removal
- 2.2 Commercial Standards
 - 2.2.1 EIA-364 Electrical Connector Test Procedure Including Environmental Classifications
 - 2.2.2 GR-1217-CORE Generic Requirements for Separable Electrical Connectors Used in Telecommunications Hardware
 - 2.2.3 GR-78-CORE Generic Requirements for the Physical Design and Manufacture of Telecommunications Products and Equipment
 - 2.2.4 IEC-512 Electromechanical Components for Electronic Equipment Basic Testing, Procedures and Measuring Methods

3.0 BASE MATERIAL and FINISHES

3.1 Contacts

- 3.1.1 Signal contacts are high performance copper alloy. Contacts are plated with a noble metal at the separable interface and PCB interface per EGS205.
- 3.1.2 Shield blades are high performance copper alloy. Contacts are plated with a noble metal at the separable interface per EGS205. The PCB interface is generally plated with Sn.

Notes:

1. All contacts meet lead free requirements, refer to EGS205

3.2 Sub Components –

Component	Material	Specification	
Insulative Dielectric	Glass Reinforced Polyester (LCP)	UL 94V-0 Rating, Color natural	
Non-Insulative Plastic	Reinforced Nylon	UL 94V-0 Rating, Color Black	
Stiffener	Stainless steel, Type 301	N/A	
Screw Down Endcaps	Die Cast Zinc	Per EGS205	
Backplane Guide Pins and Keys	Stainless steel	QQ-S-764, CL 303 or 303 SE	
		Condition A	

4.0 <u>LENGTH OF TRACES & MATED BULK RESISTANCE</u> – <u>Paladin HD and HD2TM</u>

4.1 Paladin HD and HD2 Direct Orthogonal Connectors

Differential Pair	Contact Rows	DC Trace Length (mm)	DO Trace Length(mm)	DC Resistance (mΩ)	DO Resistance (mΩ)
Signal Pair 1	A, B	10.2	22.3	21	44
Ground Shield Pair 1	Contacts 1-4	12.0	20.5	11	16
Signal Pair 2	C, D	14.7	26.8	25	48
Ground Shield Pair 2	Contacts 1-4	16.5	25.0	12	17
Signal Pair 3	E, F	19.1	31.2	29	52
Ground Shield Pair 3	Contacts 1-4	20.9	29.4	13	18
Signal Pair 4	G, H	23.6	59.3	34	57
Ground Shield Pair 4	Contacts 1-4	25.4	57.5	13	18
Signal Pair 5	J, K	29.3	41.4	39	62
Ground Shield Pair 5	Contacts 1-4	31.1	39.6	16	21
Signal Pair 6	L, M	33.8	45.9	42	65
Ground Shield Pair 6	Contacts 1-4	35.6	44.1	19	24
Signal Pair 7	N, P	38.2	50.3	51	74
Ground Shield Pair 7	Contacts 1-4	40.0	48.5	20	25
Signal Pair 8	Q, R	42.7	54.8	56	79
Ground Shield Pair 8	Contacts 1-4	44.5	53.0	20	25
Signal Pair 9	S,T	48.4	60.5	59	82
Ground Shield Pair 9	Contacts 1-4	50.2	58.7	21	26
Signal Pair 10	U,V	52.8	64.9	65	88
Ground Shield Pair 10	Contacts 1-4	54.7	63.1	21	26
Signal Pair 11	W,X	57.3	69.4	67	90
Ground Shield Pair 11	Contacts 1-4	59.1	67.6	21	26
Signal Pair 12	Y,Z	61.8	73.9	72	95
Ground Shield Pair 12	Contacts 1-4	63.6	72.1	25	30

Notes:

- 2. Mated bulk resistance values are typical values.
- 3. Mated trace lengths are taken from the DC board surface to the mating interface (assumes fully mated), including the compliant pin interface and compression springs.
- 4. For mated Direct Ortho total resistance add the DC resistance and the DO resistance based on the appropriate pairs.
 - a. Refer to TB2357 for Direct Ortho pin out mapping.
- 5. Ground Shield and Signal Contacts are as follows (GC = Ground Contact, SH = Shadow via and S = Signal):

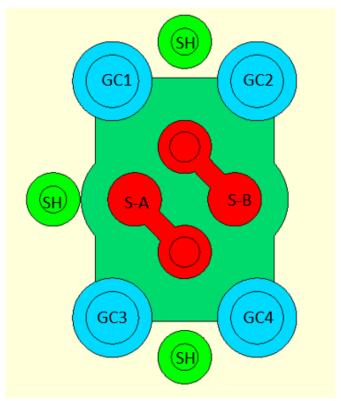


Figure 1: Footprint naming convention.

5.0 ELECTRICAL RATINGS

Description	Value
Mating Interface Contact Resistance Change	10mΩ Maximum
Compliant Pin to Plated Through Hole Resistance	1 mΩ Maximum
Insulation Resistance	1000 MegaΩ
Dielectric Withstanding Voltage	250 VAC Peak
Signal Compression Spring to Pad Resistance	10 mΩ

6.0 CURRENT AND TEMPERATURE RATINGS

Description	Value
Maximum operating temperature rating	85°C ⁽⁵⁾
Minimum operating temperature rating	-40°C

Notes:

6. Per EIA-364-1000 the testing for 85°C (10 years) Field Temperature and Field Life at 105°C for 1,000 hours.

7.0 <u>MECHANICAL RATINGS</u>

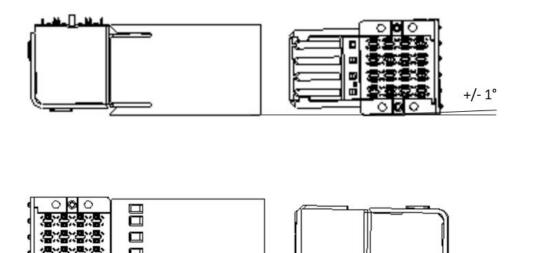
7.1 **Mechanical Performance**

Paladin HD and HD2 TM		Value		
Description	Grams	Newtons		
Signal Contact Normal Force (End of Life)	30 min (EOL)	0.29 min (EOL)		
Shield Contact Normal Force (End of Life)	30 min (EOL)	0.29 min (EOL)		
Signal and Shield Engagement Force ⁽⁷⁾⁽⁸⁾	120 max	1.18 max		
Signal and Shield Separation Force ⁽⁷⁾⁽⁹⁾	40 min	0.39 min		
Signal and Shield Durability	Rated for 200 N	Nating Cycles		
Contact Mechanical Wipe Minimum Values	Signal	2.0mm/1.5mm		
	Shield	2.5mm		

Notes:

- 7. These values are maximum and minimum expected forces, averaged over one differential pair in a connector. This data is to be used for purposes of system mechanical sizing.
- 8. The average Signal and Shield Engagement Force shall be no greater than 120 grams (1.18 N) per one differential pair in a connector.
- 9. The average Signal and Shield Separation Force values shall be no less than 40 grams (0.39N) per one differential pair in a connector.
- 10. Sample Calculation: For a 4X4 connector, there are 16 differential pairs per connector allowing a maximum engagement force of: 1920 grams (120X16).

7.2 **Connector Mating Angle**

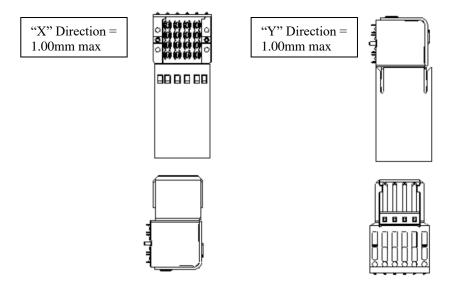


7.2.1 The maximum mating angle allowable in the X and Y axis is 1 degree.

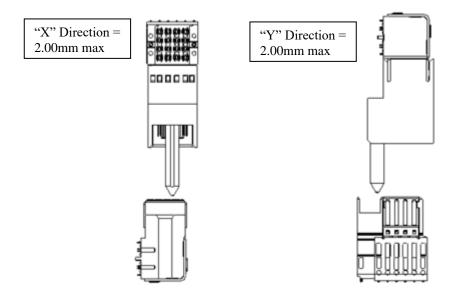
+/- 1°

7.3 **Connector Gather-ability**

7.3.1 Without Guide Module X & Y = 1 mm Max



7.3.2 With Guide Module X & Y = 2mm Max



7.4 **Sequencing chart**

7.4.1 Consult factory for sequencing charts.

8.0 COMPLIANT PIN INTERFACE Paladin HD and HD2

Description	Value per Pin, lbs	
0.0137" or 0.0145" Drill (Paladin HD and l	HD2 DC/BMA Pin)	
Shield Compliant Pin Insertion	5.0 Maximum ⁽¹⁰⁾	
Shield Compliant Pin Retention	0.2 Minimum ⁽¹¹⁾	
Signal Compression Spring Force	40 Grams minimum EOL	

- 8.1 Radial hole deformation not to exceed 70μm (0.0015") measured from drilled hole.
- 8.2 Axial hole deformation not to exceed $50\mu m$ (0.00197") per IEC 60352-5 measured in the vertical plane.
- 8.3 Three pin insertions max per Plated Through Holes (PTH).

Notes:

- 10. Ensure press machine can reach maximum force required to press connector with a safety factor of 1.2 [Maximum force= (Max value per pin)(1.2) (Number of pins on connector)].
- 11. The average compliant pin retention shall not be less than 0.2 lbf.
- 12. Refer to technical bulletin TB-2360, Paladin HD and HD2 Routing Guidelines, for drilled and finished hole requirements. Refer to technical bulletin TB-2357, Paladin HD and HD2 Direct Ortho General Guidelines for pin locations and callouts
- 13. Signal compression to PCB pad interface supports 3 placements (2x rework)

9.0 QUALIFICATION TESTING

- 9.1 Sample Selection: Refer to Section 13 for minimum recommended connector sample size.
- 9.2 Test Sequence: Qualification testing shall be performed per the sequences listed in Section 13 of this document.
- 9.3 The qualification for the Paladin HD and HD2 product line was performed with the 12 Pair x 12 position interconnect and by similarity all other derivatives of the product line are considered qualified.

10.0 REQUALIFICATION TESTING

10.1 If changes affecting form, fit or function are made to the product or to the manufacturing process, Product Engineering and Mechanical Integrity Engineering shall coordinate requalification testing of all or part of the original testing sequence as required.

11.0 ACCEPTANCE

11.1 Acceptance is based on verification that the product meets the requirements of Section 12. Failures attributed to equipment, test set-up, or operator deficiencies shall not disqualify the product. If product failure occurs, corrective action shall be taken and samples resubmitted for qualification. Verification of corrective action is required before re-submittal.

12.0 SPECIFICATION SUMMARY

12.1 Material

Parameters	Typical Specification	Paladin HD and HD2	Reference Document
		Value	
Plating Integrity	Acceptable Porosity	No more than 3 Pores per mating surface ⁽¹⁴⁾	EIA-364-TP53 Exposed to nitric vapors
Contact Metallization	Noble metal over Ni	Noble metal over Ni per EGS205	GR-1217-CORE Per section 6.1.8
Durability	200 Cycles	200 Cycles	GR-1217-CORE Per paragraph 9.1.1.2 EIA-364-TP09
Surface Finish	Surface finish is 16 RMS or otherwise specified	16 RMS on mating surfaces	GR-1217-CORE Per section 6.1.9
Lubrication	Must be present on all backplane blades/shields	Must be present on all backplane male pins/shield receptacles	GR-1217-CORE R5-67
Flammability Rating	94V-0	Must Pass Requirement	UL94

Notes:

14. Measured on as plated material prior to connector assembly.

12.2 Mechanical

Parameters	Specification	Paladin HD and HD2 Value	Reference Document
Contact Normal Force	30 Grams End of Life	30 Grams End of Life	GR-1217-CORE
	(EOL)	(EOL)	EIA-364-TP04
Contact Strength*	Apply 0.25 lbs. Axial	Apply 0.25 lbs. Axial	GB-1217-CORE
	Force per contact	Force per contact	Per paragraph 6.1.7
Polarization Force*	100 N (22.5 lbs)	Mate Samples 180° out of	GR-78-CORE
		Phase	Per section 4.2.2

12.3 Electrical

Parameters	Specification	Paladin HD and HD2 Value	Reference Document
Contact Resistance	Less than 10mΩ change	Less than 10mΩ change	GR-1217-CORE
Stability (LLCR)	from initial reading		Per paragraph 6.2.1 EIA-364-TP23
Compliant Pin to PTH	No change greater than $1 \text{m}\Omega^{(15)}$	No change greater than $1 \text{m}\Omega$	GR-1217-CORE
Resistance			EIA-364-TP23
	Test current 100mA and		
	20mV open circuit		
Mated Bulk Resistance	N/A	SEE SECTION 4.0	N/A
Signal Continuity*	Less than 10 nanosecond	Less than 10 nanosecond	GR-1217-CORE
	interrupt	Interrupt	
Insulation Resistance	1,000 MegaΩ	1,000 MegaΩ	GR-1217-CORE
Dielectric Withstanding	250 VAC Peak	250 VAC Peak	GR-1217-CORE
			EIA-364-TP20

Notes:

15. Due to the size of the Paladin HD and HD2 compliant pins, direct probing of the compliant pins can disturb the compliant pin and PTH interface, yielding unreliable measurements. In lieu of direct probing, ATCS has developed a process to measure the compliant pin interface resistance without directly probing the compliant pins. This method does add some bulk resistance to the measurement, which is why a change in resistance is the critical metric. This technique complies with Telcordia requirements per paragraph R5-103.

12.4 Environmental

Parameters	Specification	Paladin HD and HD2	Reference Document
		Value	
Temperature Life*	No Change in LLCR greater	10mΩ Maximum	GR-1217-CORE
	than 10mΩ	change	EIA-364-TP17
			Test condition 4
			Per paragraph 6.3.2
Thermal Shock*	No Change in LLCR greater	Same as above	GR-1217-CORE
	than 10mΩ		Per paragraph 6.3.3
			EIA-364-TP32
	25 cycles for –65°C to 105°C		
Humidity Cycling*	No Change in LLCR greater	Same as above	GR-1217-CORE
	than 10mΩ		EIA-364-TP31
			Procedure II
	Relative Humidity 90 to 95%		
	For 500 hrs		
Dust*	No Change in LLCR greater	Same as above	GR-1217-CORE
	than 10mΩ		Per paragraph 9.1.1.1
			EIA-364-TP91
Vibration*	No Change in LLCR greater	Same as above	GR-1217-CORE
	than 10mΩ		EIA-364-TP28
			Per paragraph 9.1.2.1
	Random Vibration 9.26 RMS		
Mechanical Shock*	No Change in LLCR greater	Same as above	GR-1217-CORE
	than 10mΩ		EIA-364-TP27
	50 61 6 11 111		
	50 G's for 11 milliseconds		
M: 1El : C *	Half Sine 3 axis	0 1	CD 1217 CODE
Mixed Flowing Gas*	No Change in LLCR greater	Same as above	GR-1217-CORE
	than 10mΩ		Per paragraph 9.1.3 EIA-364-TP65
	300 hrs at 105°C thermal		211 301 1103
	conditioning also included		
	tonaming and included	1	

Parameters marked with an asterisk (*) indicates that testing has not been performed/completed to this date.

13.0 <u>TELCORDIA QUALIFICATION TEST GROUP SUMMARY</u>

- 13.1 Test Groups (Minimum 100 contacts per test group.)
 - Group 1: Vibration and mechanical shock with dust and durability
 - Group 2: Thermal shock and humidity with dust and durability
 - Group 3: Temperature life, 1000 hrs @ 105°C
 - Group 4: Mixed flowing gas, 4 gases with durability-thermal conditioning included prior to test.

Note: Compliant pins and compression springs are tested separately.

- 13.2.1 Definitions:
 - 13.2.1.1 LLCR Low Level Contact Resistance
 - 13.2.1.2 DWV Dielectric Withstanding Voltage
 - 13.2.1.3 IR Insulation Resistance

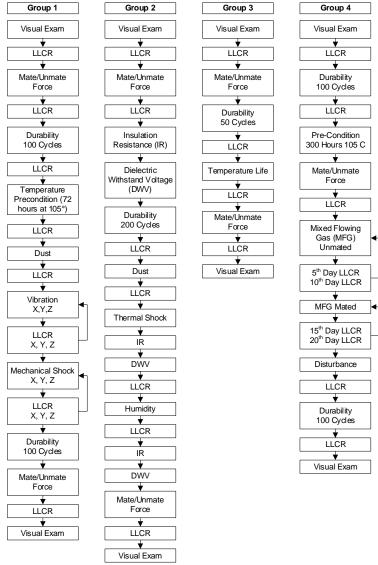


Figure 2: Telcordia Test Plan GR-1217-CORE, CENTRAL OFFICE

14.0 RESISTANCE MEASUREMENT SET-UP

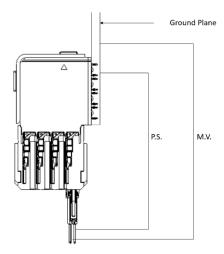


Figure 3: Shown above is an example of a typical contact resistance set-up. Kelvin 4 wire traces from connector hole to monitoring hole.

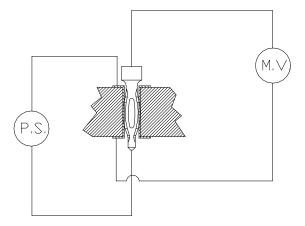


Figure 4: Typical compliant pin interface resistance (CPIR) set-up.